## Application/Control No. Applicant(s)/Patent Under Reexamination 10/074,996 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Christopher A. Revak 2131

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,775,779	08-2004	England et al.	726/26
	В	US-			
	Ċ	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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